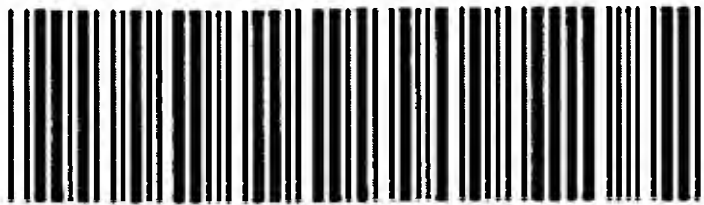


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/708,973	CHO ET AL.	
	Examiner	Art Unit	
	Matthew J. Smith	3672	

SEARCHED			
Class	Subclass	Date	Examiner
166	285, 386, 387, 381, 118, 231,	3/15/2006	<i>MS</i> MS
	135, 192,		
	241.6,		
	241.7,		
	207		
175	325.1-		
	325.7		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Consulted: W. Neuder, classes 166, 175	3/15/2006	<i>MS</i> MS